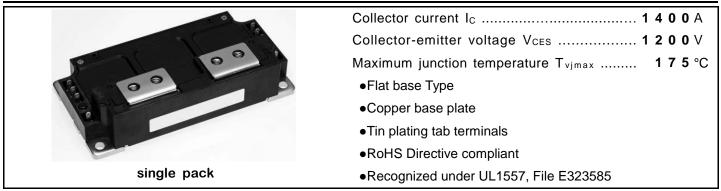


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CM1400HA-24S

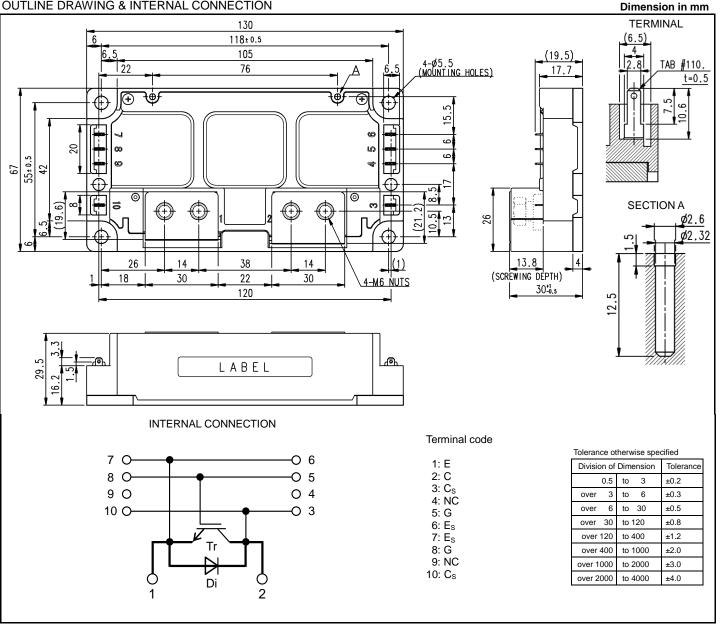
HIGH POWER SWITCHING USE INSULATED TYPE



APPLICATION

AC Motor Control, Motion/Servo Control, Power supply, Photovoltaic power, Wind power, etc.

OUTLINE DRAWING & INTERNAL CONNECTION



1

<IGBT Modules> CM1400HA-24S HIGH POWER SWITCHING USE INSULATED TYPE

MAXIMUM RATINGS (Tvj=25 °C, unless otherwise specified)

Symbol	Item	Conditions	Rating	Unit
V _{CES}	Collector-emitter voltage	G-E short-circuited	1200	V
V_{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V
I _C	Collector current	DC, T _C =94 °C (Note2, 4)	1400	
I _{CRM}	Collector current	Pulse, Repetitive (Note3)	2800	A
P _{tot}	Total power dissipation	T _C =25 °C (Note2, 4)	7140	W
IE (Note1)		DC (Note2)	1400	•
IERM (Note1)	Emitter current	Pulse, Repetitive (Note3)	2800	A
Visol	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	4000	V
T_{vjmax}	Maximum junction temperature	Instantaneous event (overload)	175	- °C
T_{Cmax}	Maximum case temperature	(Note4)	125	
T_{vjop}	Operating junction temperature	Continuous operation (under switching)	-40 ~ +150	°C
T _{stg}	Storage temperature	-	-40 ~ +125	

ELECTRICAL CHARACTERISTICS (Tvj=25 °C, unless otherwise specified)

Symbol	Item Conditions			Limits		- Unit	
Symbol			Min.	Тур.	Max.		
I _{CES}	Collector-emitter cut-off current	V _{CE} =V _{CES} , G-E short-circuited		-	-	1.0	mA
I _{GES}	Gate-emitter leakage current	V _{GE} =V _{GES} , C-E short-circuited		-	-	0.5	μA
$V_{\text{GE(th)}}$	Gate-emitter threshold voltage	I _C =140 mA, V _{CE} =10 V		5.4	6.0	6.6	V
	1	I _C =1400 A, V _{GE} =15 V,	T _{vj} =25 °C	-	1.90	2.35	V
V _{CEsat}		Refer to the figure of test circuit	T _{vj} =125 °C	-	2.10	-	
(Terminal)		(Note5)	T _{vj} =150 °C	-	2.20	-	
	Collector-emitter saturation voltage	I _C =1400 A,	T _{vj} =25 °C	-	1.80	2.25	
V _{CEsat}		V _{GE} =15 V,	T _{vj} =125 °C	-	2.00	-	V
(Chip)		(Note5)	T _{vj} =150 °C	-	2.10	-	
Cies	Input capacitance	V _{CE} =10 V, G-E short-circuited		-	-	125	nF
C _{oes}	Output capacitance			-	-	25	
Cres	Reverse transfer capacitance			-	-	2.1	
Q _G	Gate charge	V _{CC} =600 V, I _C =1400 A, V _{GE} =15 V		-	2.9	-	μC
t _{d(on)}	Turn-on delay time	$V_{CC}{=}600$ V, $I_{C}{=}1400$ A, $V_{GE}{=}{\pm}15$ V, $R_{G}{=}0$ Ω, Inductive load		-	-	600	- ns
tr	Rise time			-	-	300	
t _{d(off)}	Turn-off delay time			-	-	600	
t _f	Fall time			-	-	300	-
		I _E =1400 A, G-E short-circuited,	T _{vi} =25 °C	-	1.85	2.30	
V _{EC} (Note.1)		Refer to the figure of test circuit	T _{vj} =125 °C	-	1.90	-	V
(Terminal)		(Note5)	T _{vi} =150 °C	-	1.90	-	
	Emitter-collector voltage	I _E =1400 A,	T _{vj} =25 °C	-	1.75	2.20	
V _{EC} ^(Note.1)		G-E short-circuited,	T _{vj} =125 °C	-	1.80	-	V
(Chip)		(Note5)	T _{vi} =150 °C	-	1.80	-	
t _{rr} (Note1)	Reverse recovery time	V _{CC} =600 V, I _E =1400 A, V _{GE} =±15 V,		-	-	300	ns
Qrr (Note1)	Reverse recovery charge	$R_{\rm G}=0$ Ω, Inductive load		-	150	-	μC
Eon	Turn-on switching energy per pulse	$V_{cc}=600 \text{ V}, \text{ I}_{c}=\text{I}_{E}=1400 \text{ A},$ $V_{GE}=\pm15 \text{ V}, \text{ R}_{G}=0 \Omega, \text{ T}_{v_{1}}=150 \text{ °C},$		-	181	-	
E _{off}	Turn-off switching energy per pulse			-	161	-	mJ
Err (Note1)	Reverse recovery energy per pulse	Inductive load		-	104	-	mJ
R _{CC'+EE'}	Internal lead resistance	Main terminals-chip, Tc=25 °C (Note4)		-	0.2	-	mΩ
r _g	Internal gate resistance	- -		-	2.2	-	Ω
J	. v				1		

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THERMAL RESISTANCE CHARACTERISTICS

Item	Conditions	Limits			Unit
		Min.	Тур.	Max.	Unit
Thermal resistance	Junction to case, IGBT (Note4)	-	-	21	K/kW
	Junction to case, FWD (Note4)	-	-	32	
Contact thermal resistance	Case to heat sink, Thermal grease applied (Note4, 6)	-	18	-	K/kW
	Thermal resistance	Junction to case, IGBT (Note4) Junction to case, FWD (Note4) Contact thermal resistance Case to heat sink,	Image: Mine State S	Item Conditions Min. Typ. Thermal resistance Junction to case, IGBT (Note4) - - Contact thermal resistance Case to heat sink, - 18	Item Conditions Min. Typ. Max. Thermal resistance Junction to case, IGBT (Note4) - - 21 Junction to case, FWD (Note4) - - 32 Contact thermal resistance Case to heat sink, - 18 -

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions		Limits			Unit	
				Min.	Тур.	Max.	Unit	
Mt	Mounting torque	Main terminals	M 6 screw	3.5	4.0	4.5	N∙m	
Ms	Mounting torque	Mounting to heat sink	M 5 screw	2.5	3.0	3.5	N∙m	
ds	Creepage distance	Terminal to terminal		22.0	-	-		
		Terminal to base plate		21.9	-	-	mm	
da	Clearance	Terminal to terminal		16.5	-	-	mm	
		Terminal to base plate		12.5	-	-		
ec	Flatness of base plate	On the centerline X, Y (Note7)		-50	-	+100	μm	
m	mass	-		-	490	-	g	

*: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU. Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).

2. Junction temperature (T_{vj}) should not exceed T_{vjmax} rating.

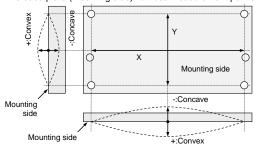
3. Pulse width and repetition rate should be such that the device junction temperature (T_{vi}) dose not exceed T_{vimax} rating.

4. Case temperature (T_c) and heat sink temperature (T_s) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.

5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.

6. Typical value is measured by using thermally conductive grease of λ =0.9 W/(m·K)/D_(C-S)=100 µm.

7. The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



8. Use the following screws when mounting the printed circuit board (PCB) on the standoffs.

The length of the screw depends on the PCB thickness (t1.0).

	Туре	Size	Tightening torque	Recommended tightening method					
(1)	PT®	K25×8	0.55 ± 0.055 N∙m						
(2)	PT®	K25×10	0.85 ± 0.085 N∙m	by handwork (equivalent to 30 r/min					
(3)	DELTA PT®	25×8	0.55 ± 0.055 N∙m	by mechanical screw driver)					
(4)	DELTA PT®	25×10	0.85 ± 0.085 N∙m	~ 600 r/min (by mechanical screw driver)					
(5)	B1 tapping screw	φ2.6×10 or φ2.6×12	0.85 ± 0.085 N∙m						

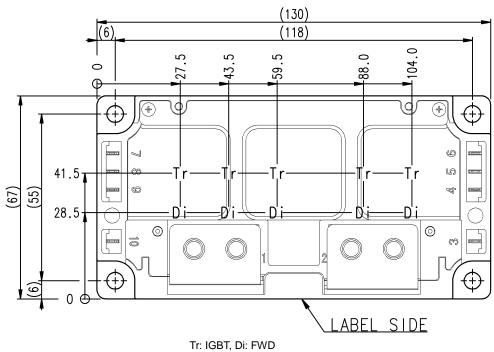
<IGBT Modules> CM1400HA-24S HIGH POWER SWITCHING USE

INSULATED TYPE

RECOMMENDED OPERATING CONDITIONS

Symbol	Item	Conditions	Limits			Unit
			Min.	Тур.	Max.	Unit
V _{cc}	(DC) Supply voltage	Applied across C-E terminals	-	600	850	V
V_{GEon}	Gate (-emitter drive) voltage	Applied across G-Es terminals	13.5	15.0	16.5	V
R _G	External gate resistance	-	0	-	15	Ω

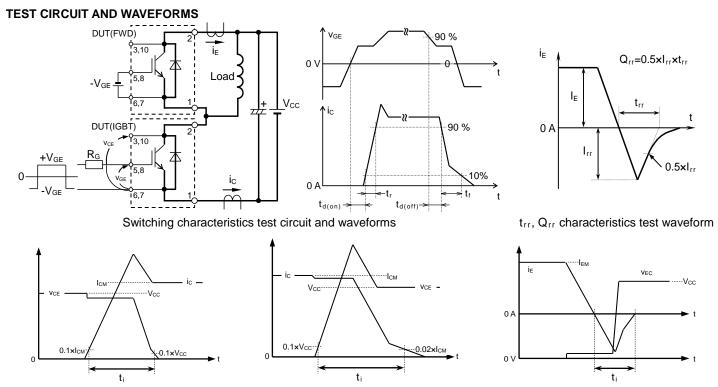
CHIP LOCATION (Top view)



Dimension in mm, tolerance: ±1 mm

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HIGH POWER SWITCHING USE INSULATED TYPE



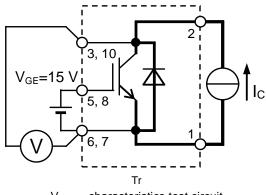
IGBT Turn-on switching energy

IGBT Turn-off switching energy

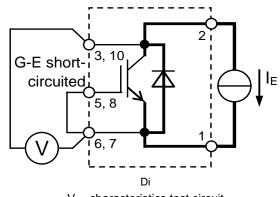
FWD Reverse recovery energy

Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

TEST CIRCUIT



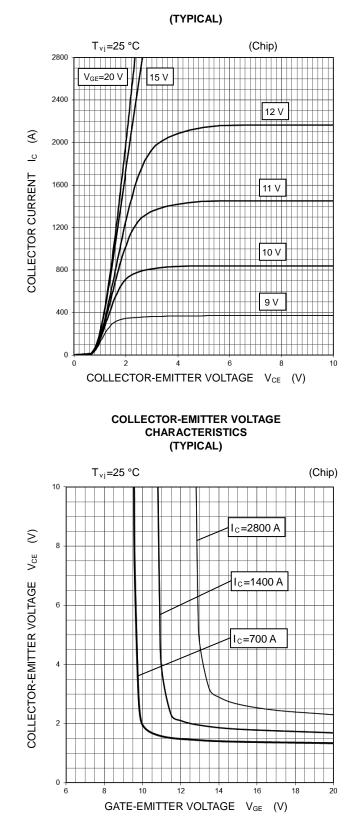
V_{CEsat} characteristics test circuit



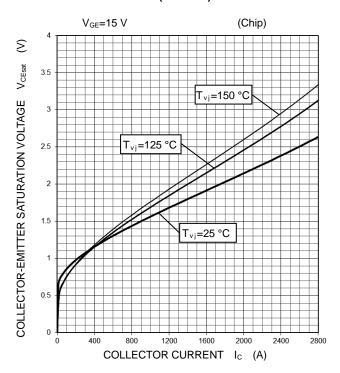
V_{EC} characteristics test circuit

PERFORMANCE CURVES

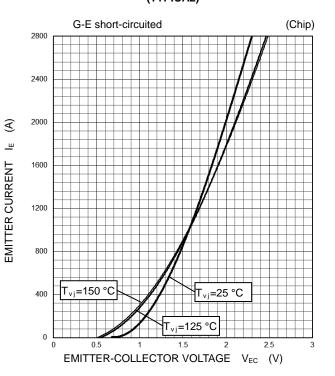




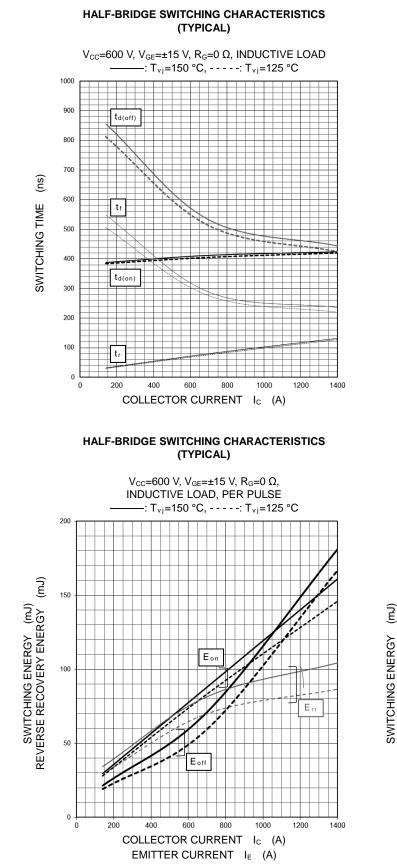


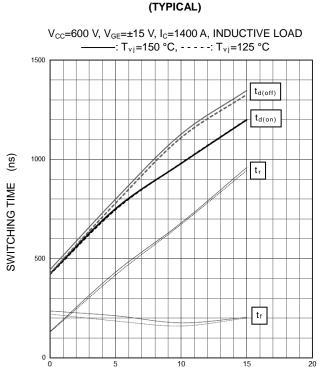


FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)



PERFORMANCE CURVES

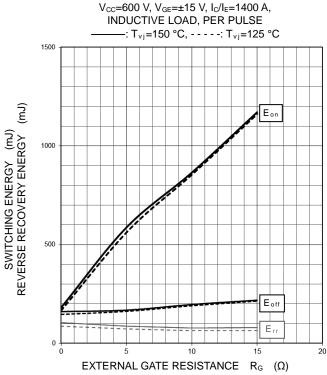




HALF-BRIDGE SWITCHING CHARACTERISTICS

HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

EXTERNAL GATE RESISTANCE R_G (Ω)



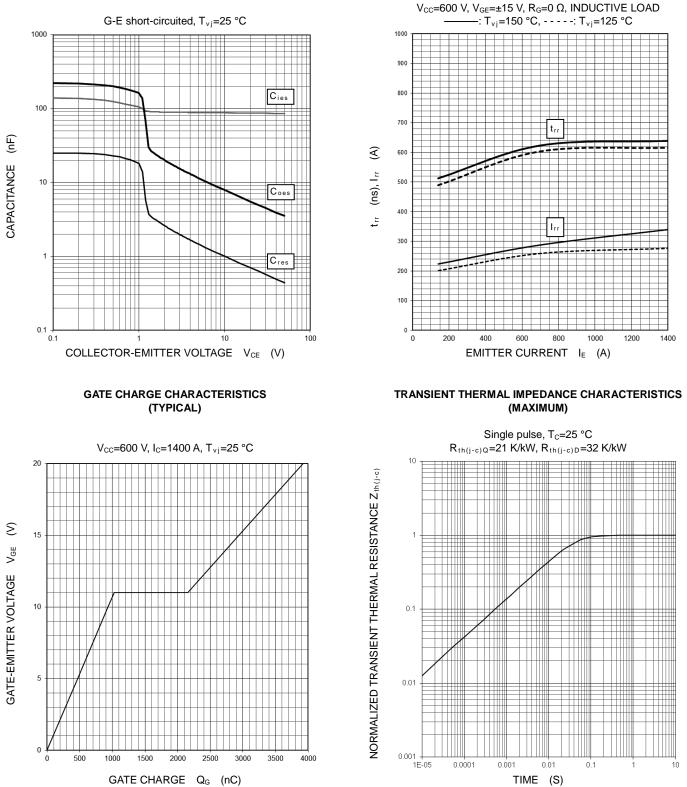
<IGBT Modules> CM1400HA-24S HIGH POWER SWITCHING USE

INSULATED TYPE

PERFORMANCE CURVES

CAPACITANCE CHARACTERISTICS

(TYPICAL)



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS

(TYPICAL)

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